

General Description

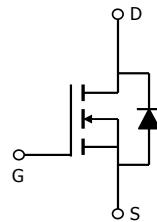
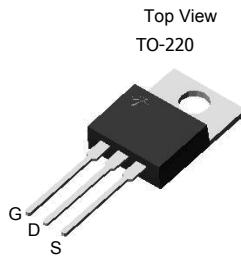
The AOT3N60 have been fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications. By providing low $R_{DS(on)}$, C_{iss} and C_{rss} along with guaranteed avalanche capability these parts can be adopted quickly into new and existing offline power supply designs.

For Halogen Free add "L" suffix to part number:
AOT3N60L

Product Summary

V_{DS}	700V@150°C
I_D (at $V_{GS}=10V$)	2.5A
$R_{DS(ON)}$ (at $V_{GS}=10V$)	<3.5Ω

100% UIS Tested
100% R_g Tested

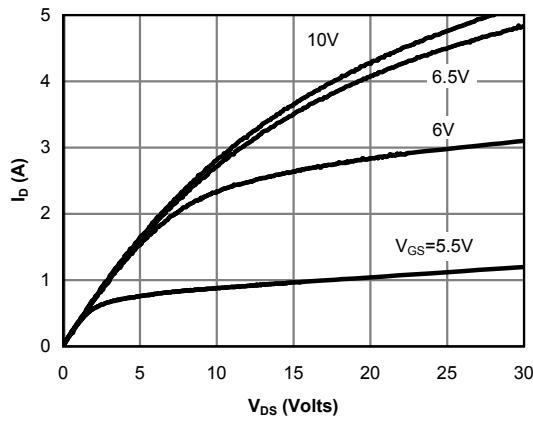
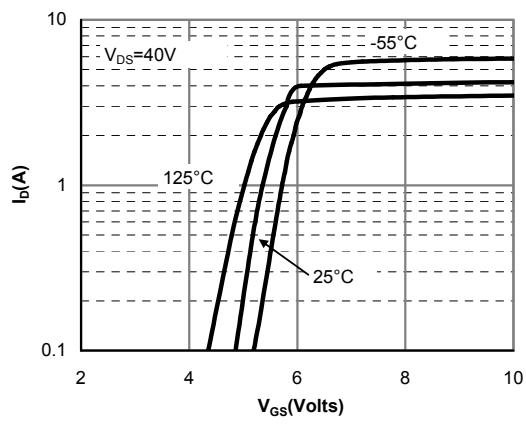
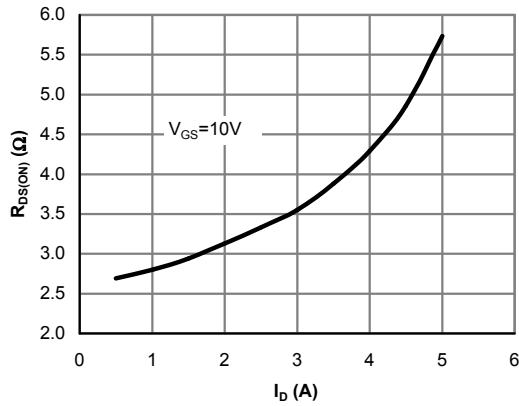
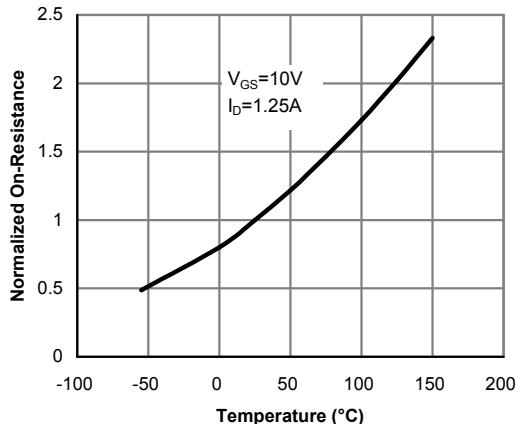
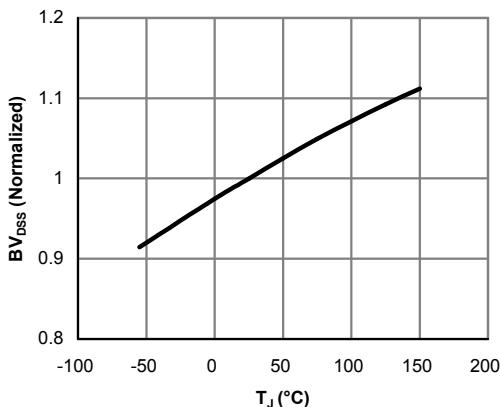
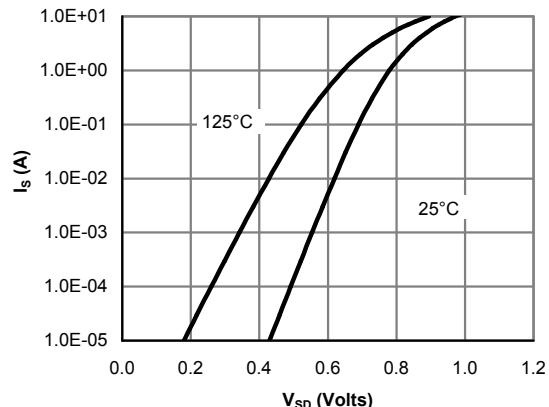


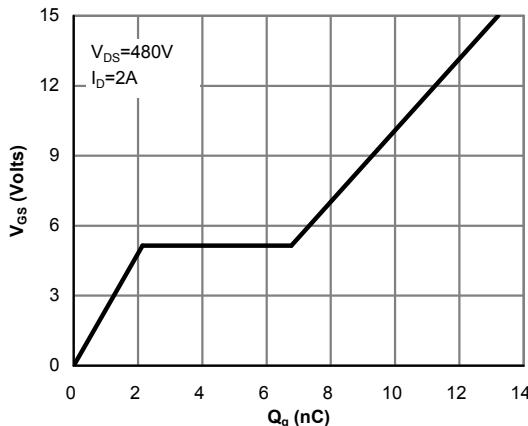
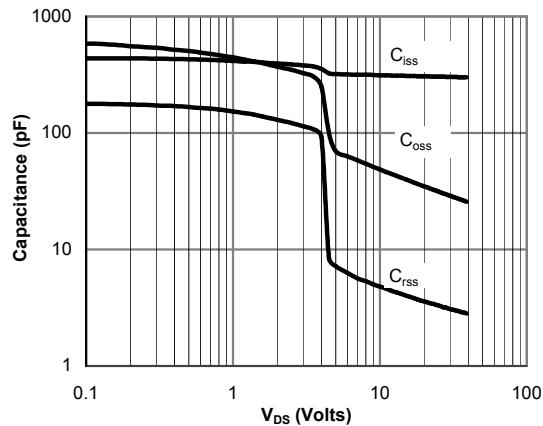
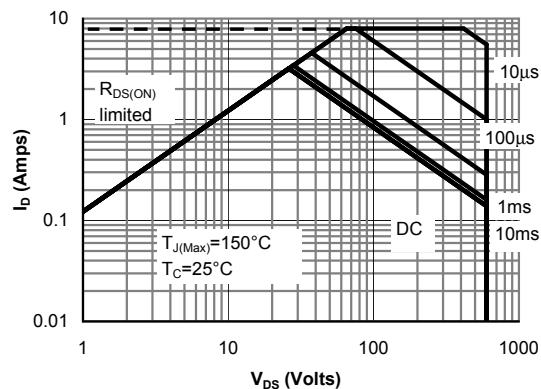
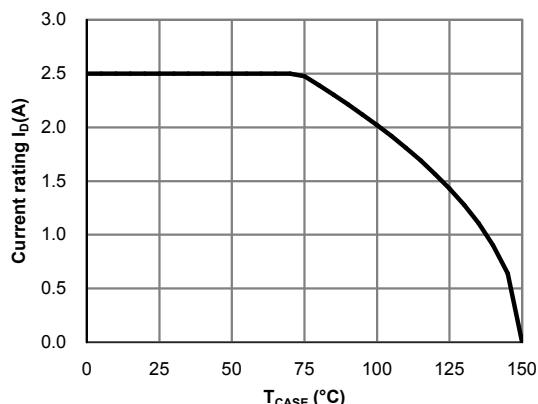
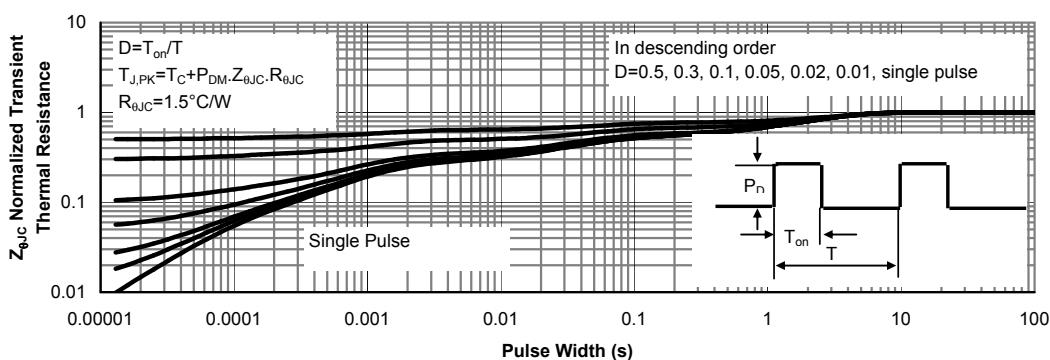
Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

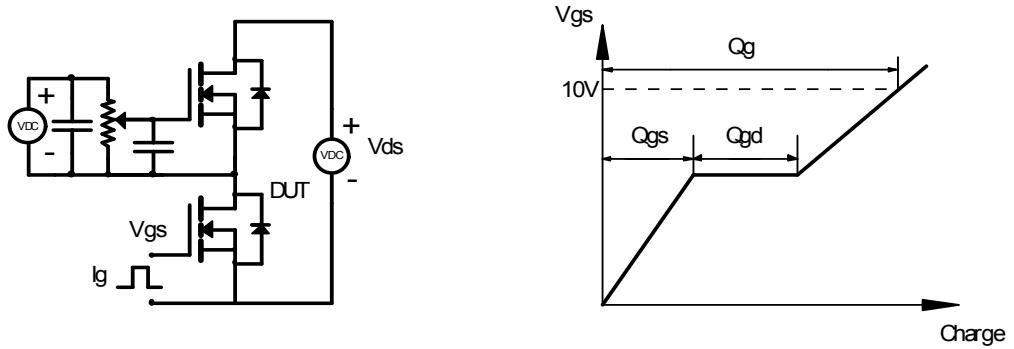
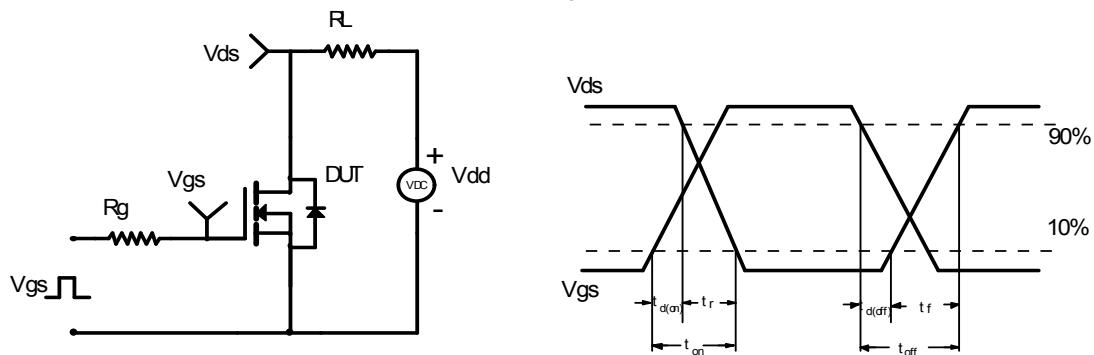
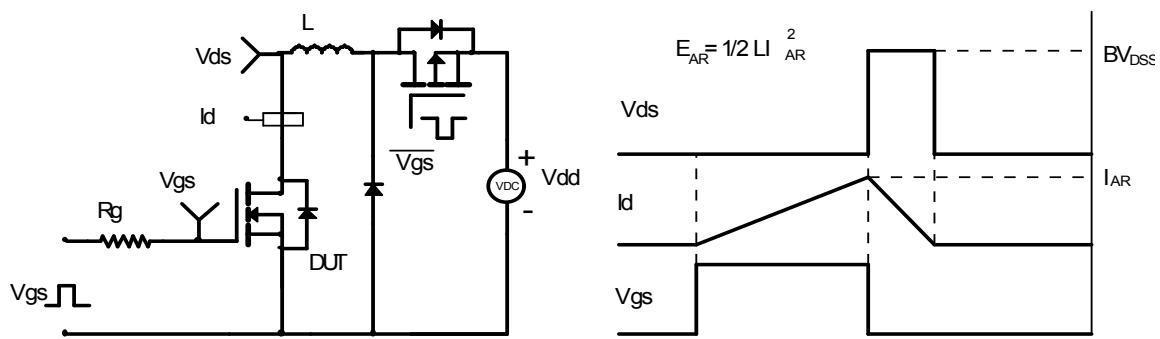
Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	600	V
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current	I_D	2.5	A
$T_C=100^\circ C$		1.9	
Pulsed Drain Current ^C	I_{DM}	8	
Avalanche Current ^C	I_{AR}	2	A
Repetitive avalanche energy ^C	E_{AR}	60	mJ
Single pulsed avalanche energy ^G	E_{AS}	120	mJ
Peak diode recovery dv/dt	dv/dt	5	V/ns
Power Dissipation ^B	P_D	83	W
Derate above $25^\circ C$		0.7	W/ $^\circ C$
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	$^\circ C$
Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	T_L	300	$^\circ C$

Thermal Characteristics

Parameter	Symbol	Typical	Maximum	Units
Maximum Junction-to-Ambient ^{A,D}	$R_{\theta JA}$	54	65	$^\circ C/W$
Maximum Case-to-sink ^A	$R_{\theta CS}$	-	0.5	$^\circ C/W$
Maximum Junction-to-Case	$R_{\theta JC}$	1.2	1.5	$^\circ C/W$

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Fig 1: On-Region Characteristics

Figure 2: Transfer Characteristics

Figure 3: On-Resistance vs. Drain Current and Gate Voltage

Figure 4: On-Resistance vs. Junction Temperature

Figure 5: Break Down vs. Junction Temperature

Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 7: Gate-Charge Characteristics

Figure 8: Capacitance Characteristics

Figure 9: Maximum Forward Biased Safe Operating Area for AOT3N60 (Note F)

Figure 10: Current De-rating (Note B)

Figure 11: Normalized Maximum Transient Thermal Impedance for AOT3N60 (Note F)

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms
